

small methods

Supporting Information

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On the Elusive Crystallography of Lithium-Rich Layered Oxides: Novel Structural Models

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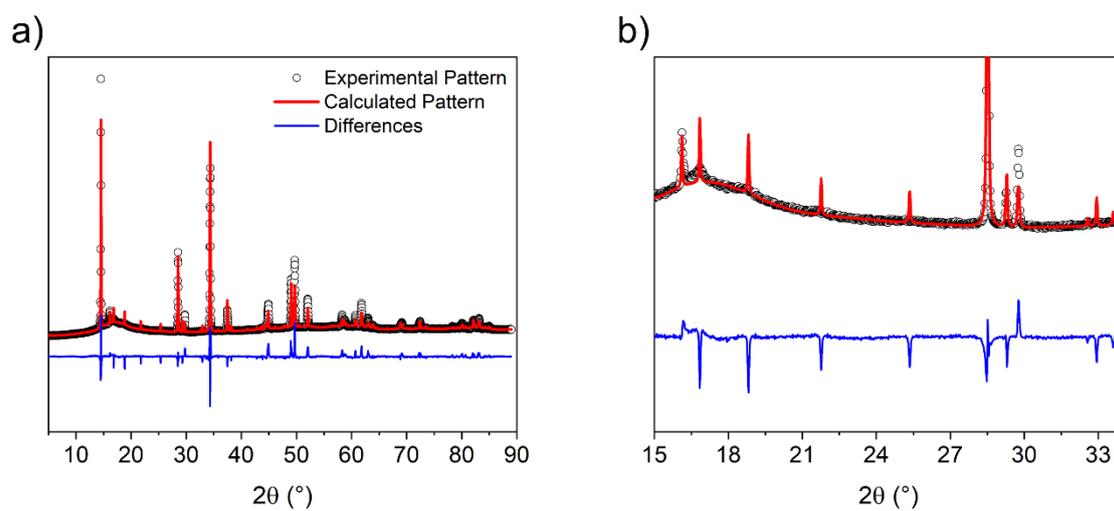


Figure S1: a) Rietveld refinement using two phases model, rhombohedral and monoclinic.

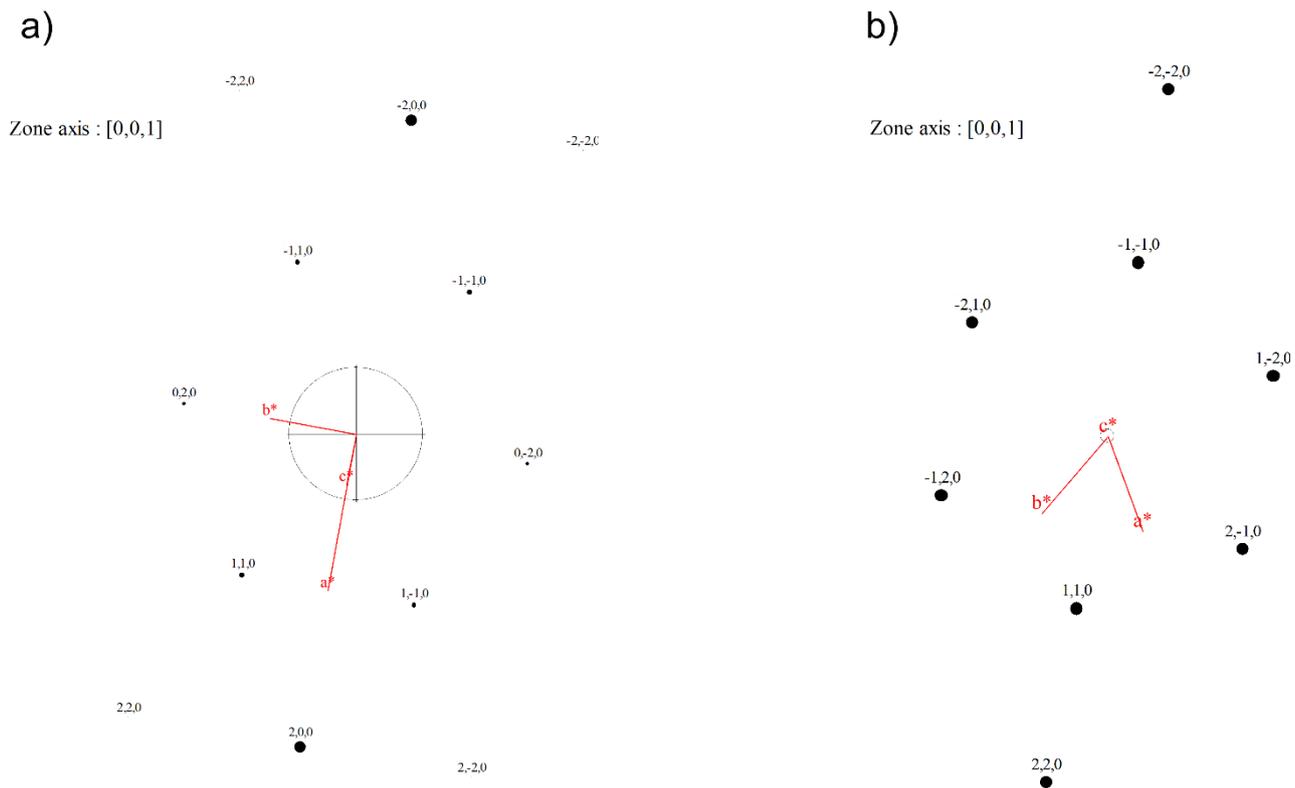


Figure S2: Single-crystal ED pattern calculated for the $[001]$ axis zone for a) $C2/m$ and b) $R-3m$ (with lattice parameters a and b 3 times larger).

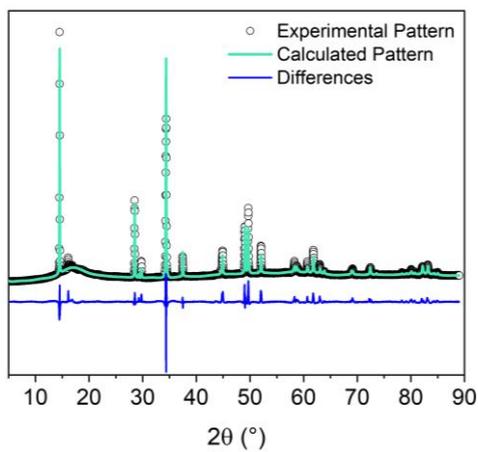


Figure S3: a) Rietveld refinement using $R-3m$ with anti-site and oxygen defects.

Table S1: Rietveld refined parameters for R-3m with anti-site and oxygen defects.	
Space group	R-3m (R=4.9%; Z=99)
Lattice parameters	a=b=2.855 c=14.247 $\alpha=\beta=90^\circ \gamma=120^\circ$
Atomic position and occupancies (Wyckoff position; OF=occupancy fraction)	
Lithium ion layer	(3b) (0 0 ½) OF(Li)=0.981 OF(TM)=0.019
Metal ions blend layer	(3a) (0 0 0) OF(Li)=0.299 OF(TM)=0.701
Oxygen ions layers	(6c) (0 0 0.746) OF=0.97

Table S2: Rietveld refined parameters for C2/M with 2b-4g site mixing.	
Space group	C 2/m (R=4%; Z=83)
Lattice parameters	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$
Atomic position and occupancies (Wyckoff position; OF=occupancy fraction)	
Lithium ion layer	(2c) (0 0 ½) OF(Li)=1
	(4h) (0 0.685 ½) OF(Li)=1
Metal ions blend layer	(2b) (0 ½ 0) OF(Li)=0.466 OF(TM)=0.534
	(4g) (0 0.169 0) OF(Li)=0.187 OF(TM)=0.813
Oxygen ions layers	(4i) (0.252 0 0.231) OF(O)=1
	(8j) (0.25 0.327 0.245) OF(O)=1

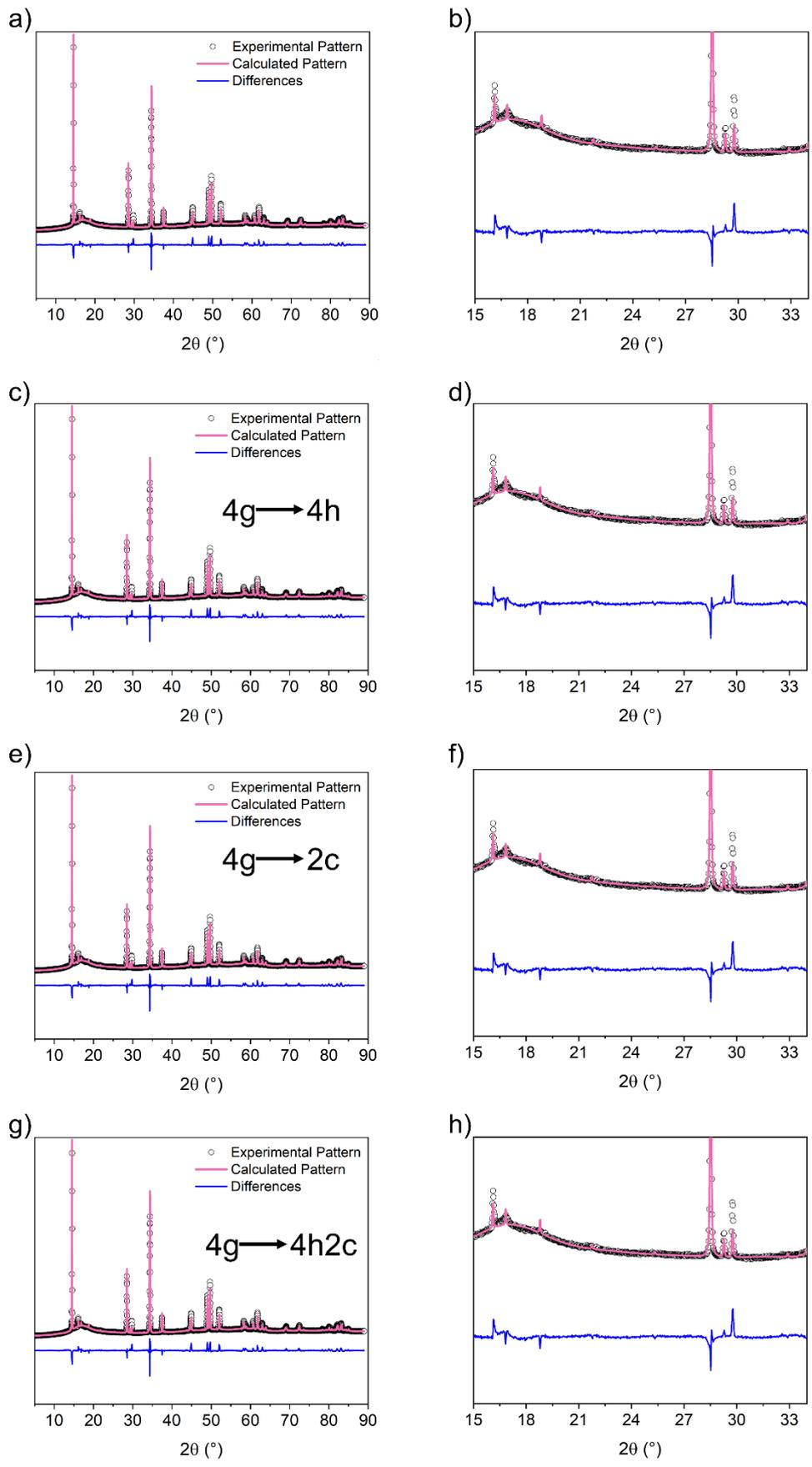


Figure S4: Rietveld refinement using C2/m with a-b) Li-TM mixing in TM layers, c-d) 4g-4h, e-f) 4g-2c and g-h) 4g-4h2c anti-site defects.

Table S3: Rietveld refined parameters for C2/M with different anti-site defects.

Space group	4g-4h (R=3.99%; Z=83)	4g-4h2c (R=3.98%; Z=83)	4g-2c (R=3.97%; Z=83)
Lattice parameters	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$
Atomic position and occupancies (Wyckoff position; OF=occupancy fraction)			
Lithium ion layer	(2c) (0 0 ½) OF(Li)=1	(2c) (0 0 ½) OF(Li)=0.9970 OF(Mn)=0.0030	(2c) (0 0 ½) OF(Li)=0.9899 OF(Mn)=0.0101
	(4h) (0 0.688 ½) OF(Li)=0.9989 OF(Mn)=0.0011	(4h) (0 0.686 ½) OF(Li)=0.9985 OF(Mn)=0.0015	(4h) (0 0.687 ½) OF(Li)=1
Metal ions blend layer	(2b) (0 ½ 0) OF(Li)=0.466 OF(Mn)=0.534	(2b) (0 ½ 0) OF(Li)=0.466 OF(Mn)=0.534	(2b) (0 ½ 0) OF(Li)=0.460 OF(Mn)=0.540
	(4g) (0 0.169 0) OF(Mn)=0.812 OF(Li)=0.188	(4g) (0 0.168 0) OF(Mn)=0.811 OF(Li)=0.188	(4g) (0 0.169 0) OF(Mn)=0.808 OF(Li)=0.192
Oxygen ions layers	(4i) (0.252 0 0.231) OF (O) = 1	(4i) (0.252 0 0.231) OF (O) = 1	(4i) (0.254 0 0.232) OF (O) = 1
	(8j) (0.25 0.327 0.246) OF (O) = 1	(8j) (0.25 0.327 0.245) OF (O) = 1	(8j) (0.249 0.326 0.245) OF (O) = 1

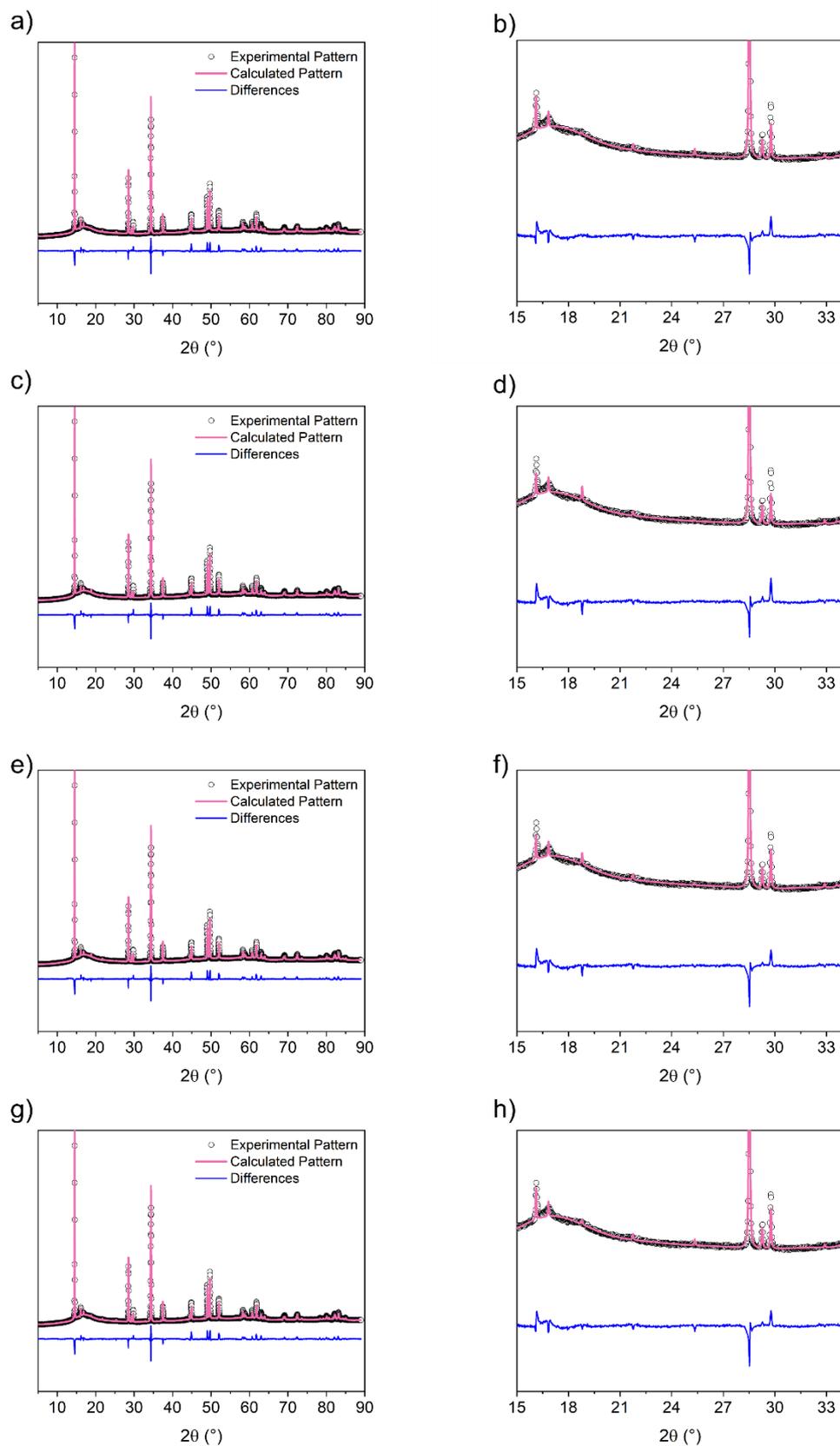


Figure S5: Calculated patterns vs experimental pattern using C2/M with anti-site defects and oxygen vacancies. a-b) oxygen vacancies in 4i site, c-d) oxygen vacancies in 8j site, e-f) oxygen vacancies in 4i and 8j sites with a constrain in the atomic fraction and g-h) oxygen vacancies in 4i and 8j sites.

Table S4: Rietveld refined parameters for C2/M with anti-site defects and oxygen vacancies.				
Space group	8j (R=3.97%; Z=77)	4i8j equal fraction (R=3.95%; Z=76)	4i8j (R=3.93%; Z=73)	4i (R=3.94%; ; Z=73)
Lattice parameters	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$	a=4.947 b=8.563 c=5.032 $\alpha=\gamma=90^\circ \beta=109.3^\circ$
Atomic position and occupancies (Wyckoff position; OF=occupancy fraction)				
Lithium ion layer	(2c) (0 0 ½) OF(Li)=0.9899 OF(Mn)=0.0101			
	(4h) (0 0.685 ½) OF(Li)=1	(4h) (0 0.685 ½) OF(Li)=1	(4h) (0 0.685 ½) OF(Li)=1	(4h) (0 0.682 ½) OF(Li)=1
Metal ions blend layer	(2b) (0 ½ 0) OF(Li)=0.466 OF(TM)=0.534	(2b) (0 ½ 0) OF(Li)=0.466 OF(TM)=0.534	(2b) (0 ½ 0) OF(Li)=0.466 OF(TM)=0.534	(2b) (0 ½ 0) OF(Li)=0.460 OF(Mn)=0.540
	(4g) (0 0.169 0) OF(Li)=0.187 OF(TM)=0.813	(4g) (0 0.169 0) OF(Li)=0.187 OF(TM)=0.813	(4g) (0 0.169 0) OF(Li)=0.187 OF(TM)=0.813	(4g) (0 0.169 0) OF(Mn)=0.808 OF(Li)=0.192
Oxygen ions layers	(4i) (0.252 0 0.232) OF (O) = 1	(4i) (0.253 0 0.235) OF (O) = 0.9324	(4i) (0.253 0 0.235) OF (O) = 0.8441	(4i) (0.252 0 0.234) OF (O) = 0.8503
	(8j) (0.25 0.326 0.245) OF (O) = 0.9659	(8j) (0.249 0.327 0.244) OF (O) = 0.9324	(8j) (0.249 0.327 0.244) OF (O) = 0.9722	(8j) (0.249 0.326 0.245) OF (O) = 1

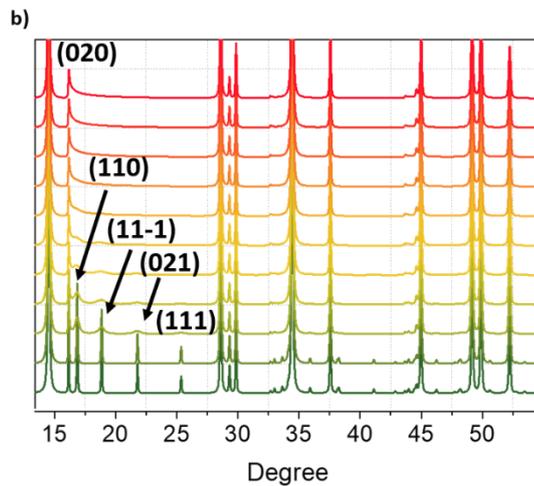
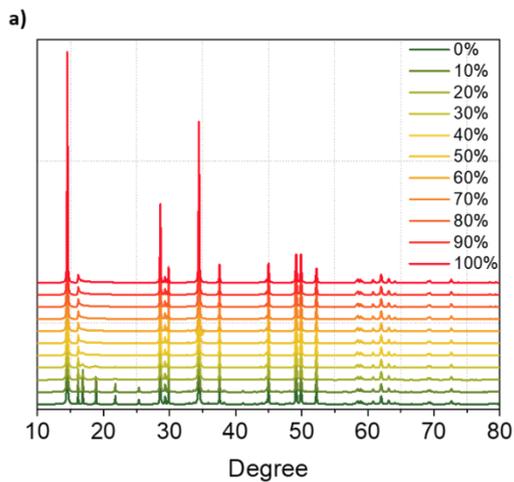


Figure S6: a) DIFFaX simulated XRD patterns with varying stacking fault probabilities. b) Enlarged view in the superstructure region.

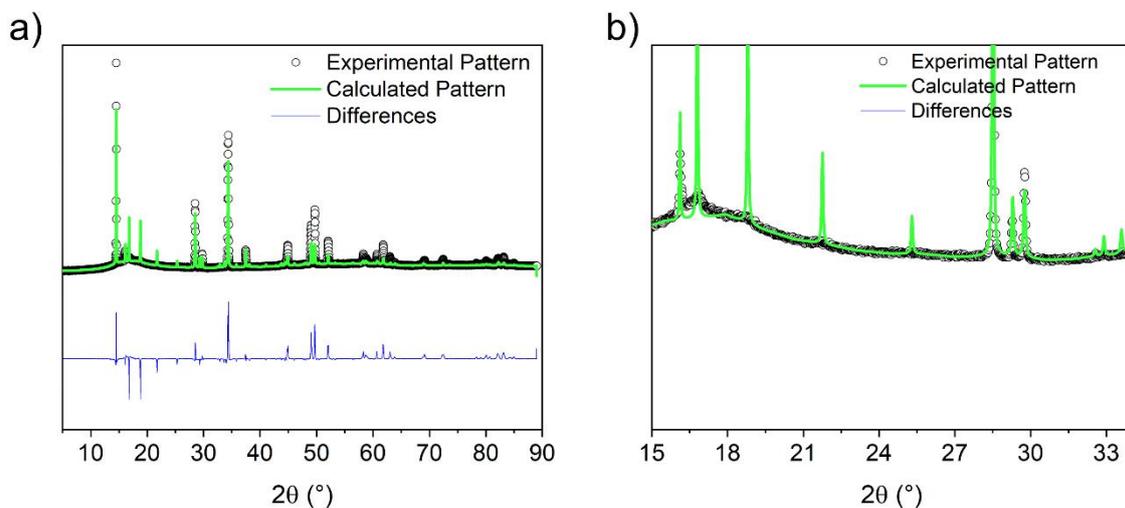


Figure S7: a) FAULTS refinement pattern without stacking faults. R-factor=8.4% and Z=95.

Table S5: Values from the FAULTS refinement without stacking faults.					
Unit cell parameters					
a, b (Å)		c (Å)		γ (°)	
4.939		4.743		60.09	
Layer compositions					
Layer	Atom	x/a	y/b	z/c	Occupancy
L1	Li	0	0	0	1
	Li	1/3	1/3	0	1
	Li	2/3	2/3	0	1
L2=L3=L4	Li	0	0	0	0.84
	TM	0	0	0	0.16
	TM	0.334	0.334	0	1
	TM	0.663	0.663	0	1
	O	0.354	-0.0089	0.249	1
	O	0.643	0.0063	-0.246	1
	O	-0.0092	0.354	-0.246	1
	O	0.337	0.660	-0.225	1
	O	0.660	0.337	0.242	1
O	0.0064	0.644	0.248	1	

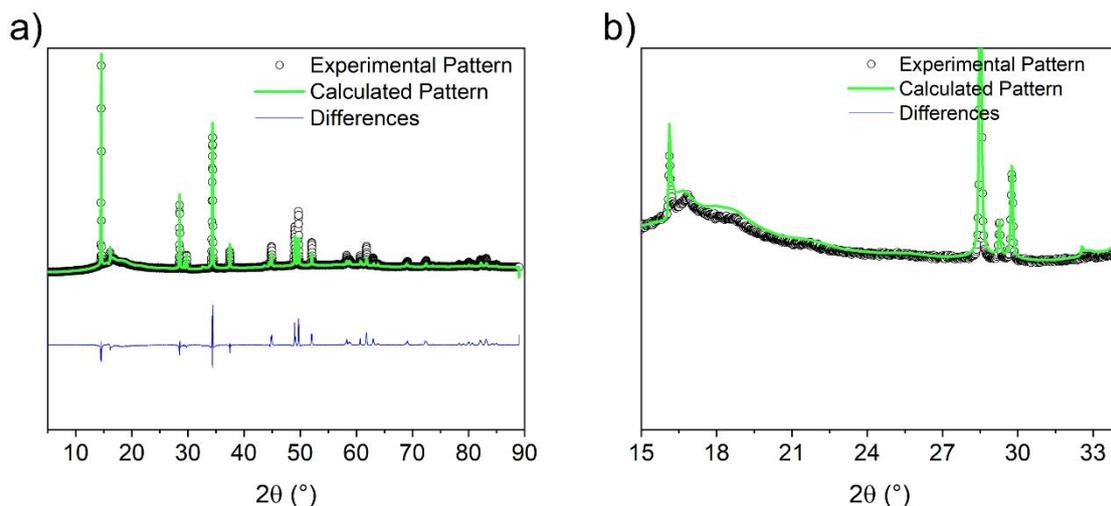


Figure S8: a) FAULTS refinement pattern. Magnified view of the refined data in the 15–25° 2 θ range. R-factor=6.7% and Z=90.

Table S6: Values from the FAULTS refinement with staking faults (around 48%).

Unit cell parameters					
a, b (Å)		c (Å)		γ (°)	
4.939		4.743		60.09	
Layer compositions					
Layer	Atom	x/a	y/b	z/c	Occupancy
L1	Li	0	0	0	1
	Li	1/3	1/3	0	1
	Li	2/3	2/3	0	1
L2=L3=L4	Li	0	0	0	0.84
	TM	0	0	0	0.16
	TM	0.337	0.337	0	1
	Li	0.337	0.337	0	1
	TM	0.662	0.662	0	1
	Li	0.662	0.662	0	1
	O	0.355	-0.0055	0.252	1
	O	0.644	0.0023	-0.251	1
	O	-0.0021	0.360	-0.252	1
	O	0.331	0.667	-0.244	1
	O	0.668	0.330	0.245	1
O	0.020	0.636	0.253	1	

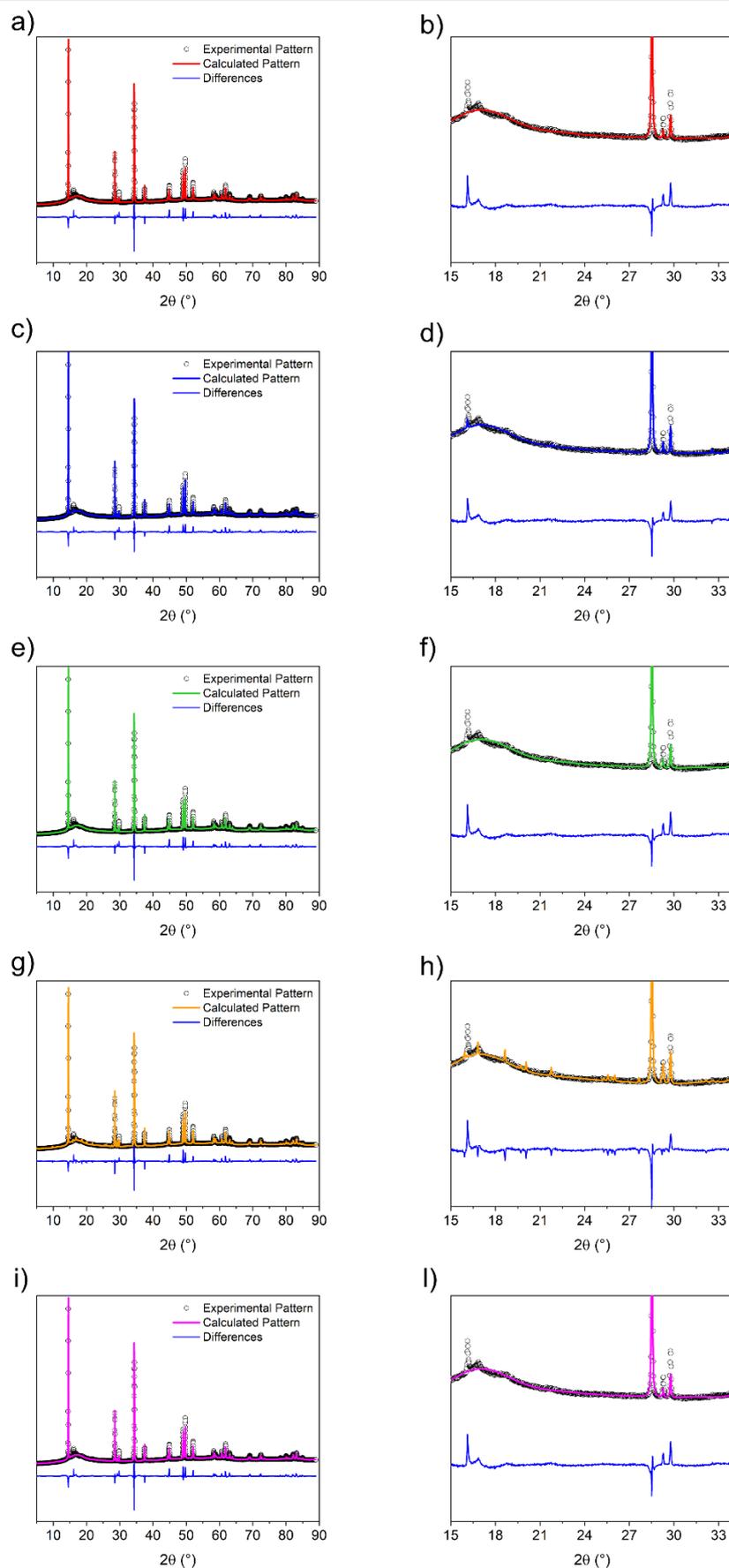


Figure S9: Comparison of Rietveld refinements results using a-b) RC_3a, c-d) RC_3b, e-f) RC_3c, g-h) RC_3a_3b and i-l) RC_3a_b_ac unit cell.

Table S7: Rietveld refined parameters for supercells.

	R_C_3a	R_C_3b	R_C_3c	R_C_3a_3b	R_C_3a_b_ac
Lithium ion layer	(2d) (0 ½ ½) OF(Li)=1	(2d) (0 ½ ½) OF(Li)=1	(2d) (0 ½ ½) OF(Li)=1	(2d) (0 ½ ½) OF(Li)=1	(2c) (0 0 ½) OF(Li)=1
	(4i) (0.833 0 0.5) OF(Li)=1	(4h) (0 0.825 0.5) OF(Li)=1	(4i) (0.5 0 0.845) OF(Li)=1	(4h) (0 0.823 ½) OF(Li)=1	(4i) (0.667 0 0.5) OF(Li)=1
				(4i) (0.166 0 0.479) OF(Li)=1	
(8j) (0.833 0.328 0.49) OF(Li)=1					
Metal ions blend layer	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72
	(4i) (0.666 0 -0.006) OF(Li)=0.28 OF(TM)=0.72	(4g) (0 0.669 0) OF(Li)=0.28 OF(TM)=0.72	(4i) (0.004 0 0.668) OF(Li)=0.28 OF(TM)=0.72	(4g) (0 0.66 0) OF(Li)=0.28 OF(TM)=0.72	(4i) (0.67 0 -0.003) OF(Li)=0.28 OF(TM)=0.72
				(4i) (0.331 0 -0.014) OF(Li)=0.28 OF(TM)=0.72	
(4i) (0.665 0.337 0.007) OF(Li)=0.28 OF(TM)=0.72					
Oxygen ions layers	(4i) (0.914 0 0.266) OF(O)=1	(4i) (0.708 0 0.217) OF(O)=1	(4i) (0.752 0 0.747) OF(O)=1	(4i) (0.085 0 0.739) OF(O)=1	(4i) (0.826 0 0.266) OF(O)=1
	(4i) (0.585 0 0.256) OF(O)=1 (4i) (0.248 0 0.266) OF(O)=1	(8j) (0.244 0.319 0.726) OF(O)=1	(4i) (0.746 0 0.43) OF(O)=1	(8j) (0.919 0.37 0.294) OF(O)=1	(4i) (0.504 0 0.232) OF(O)=1
			(4i) (0.734 0 0.08) OF(O)=1	(4i) (0.419 0 0.773) OF(O)=1	(4i) (0.156 0 0.277) OF(O)=1
				(8j) (0.583 0.339 0.307) OF(O)=1	
(4i) (0.754 0 0.768) OF(O)=1	(8j) (0.251 0.345 0.282) OF(O)=1				

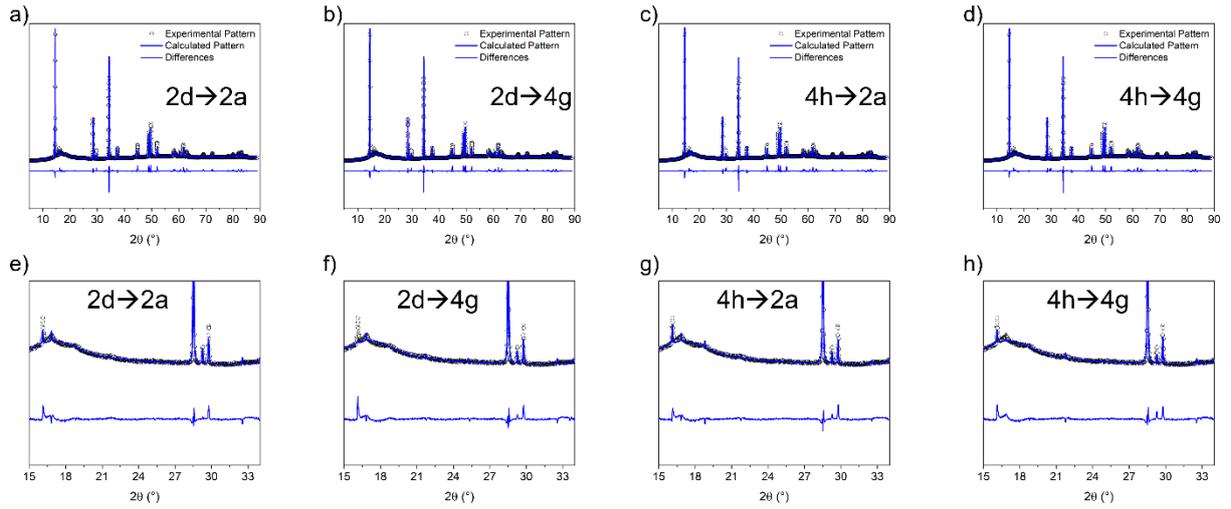


Figure S10: Calculated patterns vs experimental pattern using RC_3b with anti-site defects.

Table S8: Rietveld refined parameters for RC_3b with antisite defects.

	2d2a (Z=79)	4h4g (Z=79)	2d4g (Z=79)	4h2a (Z=79)
Lithium ion layer	(2d) (0 ½ ½) OF(Li)=0.9195 OF(TM)=0.0805	(2d) (0 ½ ½) OF(Li)=1	(2d) (0 ½ ½) OF(Li)=0.927 OF(TM)=0.073	(2d) (0 ½ ½) OF(Li)=1
	(4h) (0 0.814 0.5) OF(Li)=1	(4h) (0 0.823 0.5) OF(Li)=0.959 OF(Ni)=0.0410	(4h) (0 0.825 0.5) OF(Li)=1	(4h) (0 0.815 0.5) OF(Li)=0.967 OF(Ni)=0.033
Metal ions blend layer	(2a) (0 0 0) OF(Li)=0.3605 OF(TM)=0.6395	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.28 OF(TM)=0.72	(2a) (0 0 0) OF(Li)=0.346 OF(TM)=0.654
	(4g) (0 0.667 0) OF(Li)=0.28 OF(TM)=0.72	(4g) (0 0.668 0) OF(Li)=0.321 OF(TM)=0.679	(4g) (0 0.668 0) OF(Li)=0.3165 OF(TM)=0.6835	(4g) (0 0.667 0) OF(Li)=0.28 OF(TM)=0.72
Oxygen ions layers	(4i) (0.746 0 0.273) OF(O)=1	(4i) (0.728 0 0.237) OF(O)=1	(4i) (0.732 0 0.252) OF(O)=1	(4i) (0.732 0 0.251) OF(O)=1
	(8j) (0.246 0.314 0.741) OF(O)=1	(8j) (0.236 0.316 0.721) OF(O)=1	(8j) (0.237 0.319 0.728) OF(O)=1	(8j) (0.239 0.319 0.730) OF(O)=1

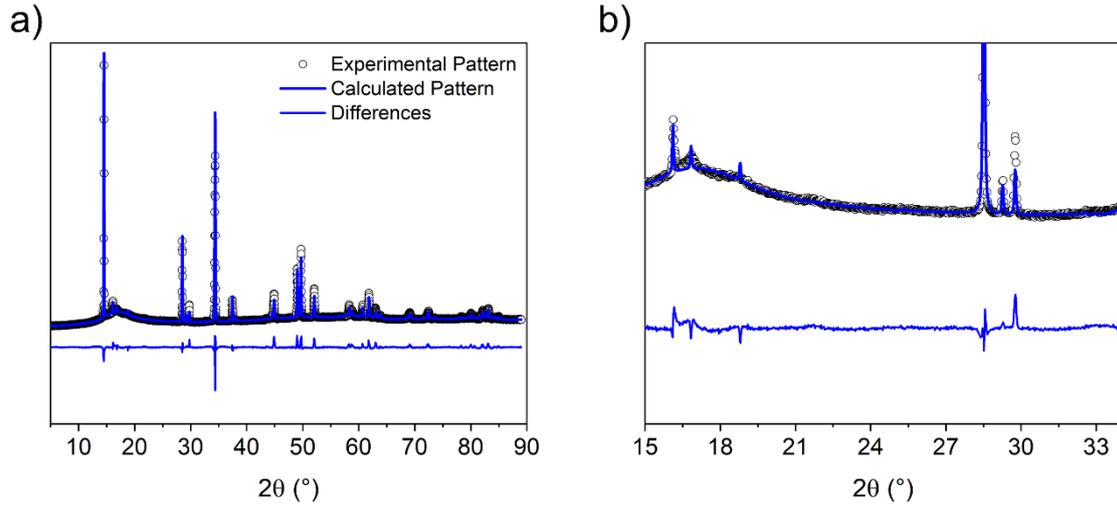


Figure S11: Calculated patterns vs experimental pattern using RC_3b with anti-site defects and Li-TM mixing (4g-2a).

Table S9: Rietveld refined parameters for RC_3b with Li-TM mixing and 4h2a anti site defects.	
	2d2a ((Z=76)
Lithium ion layer	(2d) (0 ½ ½) OF(Li)=0.9195 OF(TM)=0.0805
	(4h) (0 0.814 0.5) OF(Li)=1
Metal ions blend layer	(2a) (0 0 0) OF(Li)=0.3645 OF(TM)=0.5714
	(4g) (0 0.667 0) OF(Li)=0.2377 OF(TM)=0.7623
Oxygen ions layers	(4i) (0.746 0 0.273) OF(O)=1
	(8j) (0.246 0.314 0.741) OF(O)=1

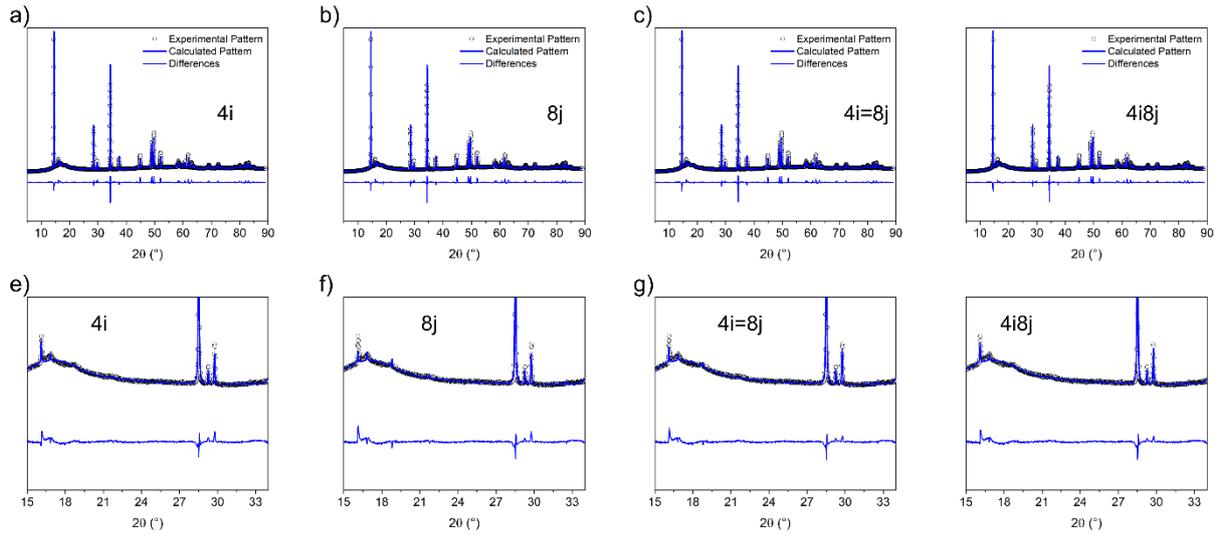


Figure S12: Calculated patterns vs experimental pattern using RC_3b with oxygen vacancies.

Table S10: Rietveld refined parameters for RC_3b with oxygen vacancies.

	4i (Z=73)	8j (Z=72)	4i=8j (Z=70)	4i8j (Z=70)
Lithium ion layer	(2d) (0 ½ ½) OF(Li)=0.9195 OF(TM)=0.0805			
	(4h) (0 0.814 0.5) OF(Li)=1			
Metal ions blend layer	(2a) (0 0 0) OF(Li)=0.3645 OF(TM)=0.5714			
	(4g) (0 0.667 0) OF(Li)=0.2377 OF(TM)=0.7623			
Oxygen ions layers	(4i) (0.732 0 0.245) OF(O)=0.8661	(4i) (0.732 0 0.247) OF(O)=1	(4i) (0.732 0 0.243) OF(O)=0.9259	(4i) (0.733 0 0.242) OF(O)=0.8661
	(8j) (0.241 0.322 0.730) OF(O)=1	(8j) (0.239 0.321 0.730) OF(O)=0.9341	(8j) (0.240 0.321 0.723) OF(O)=0.9259	(8j) (0.242 0.322 0.730) OF(O)=0.9513

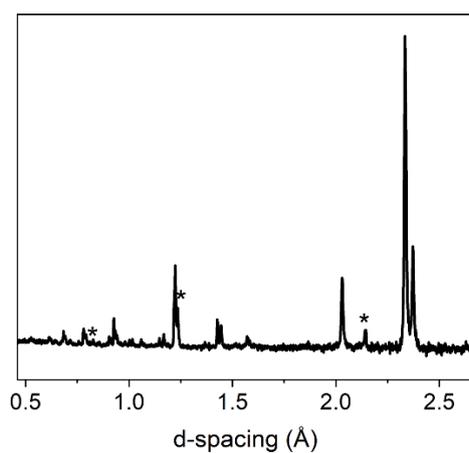


Figure S13: Neutron Diffraction data of $\text{Li}_{1.28}\text{Mn}_{0.54}\text{Ni}_{0.13}\text{Co}_{0.02}\text{Al}_{0.03}\text{O}_2$ from bank 5 detector.

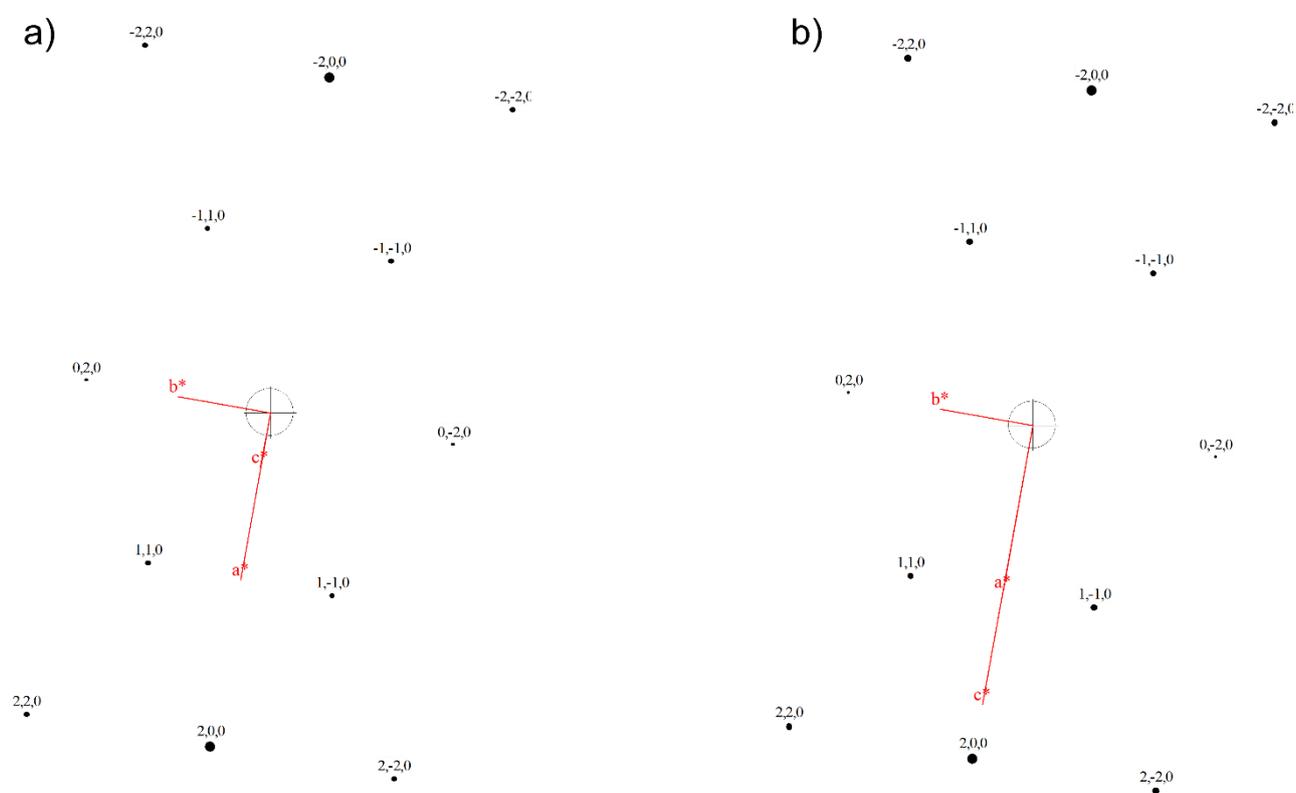


Figure S14: Single-crystal ED pattern along the $[001]$ axis zone for a) M_{def} and b) SC_{def} .

Table S11: Rietveld refined lattice parameters obtained from Neutron Diffraction pattern.

	a (Å)	b (Å)	c (Å)	β (°)
M_{def}	4.938	8.555	5.022	109.24
SC_{def}	9.625	8.553	5.022	151.01